

## MOS FIELD EFFECT TRANSISTOR **2SK3377**

### SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

### **DESCRIPTION**

The 2SK3377 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

### **FEATURES**

- Low On-state Resistance
- ★ RDS(on)1 = 44 m $\Omega$  MAX. (VGS = 10 V, ID = 10 A)
- $\bigstar$  RDS(on)2 = 78 m $\Omega$  MAX. (VGS = 4.0 V, ID = 10 A)
- ★ Low Ciss : Ciss = 760 pF TYP.
  - Built-in Gate Protection Diode
  - TO-251/TO-252 package

### **ORDERING INFORMATION**

PART NUMBER	PACKAGE		
2SK3377	TO-251		
2SK3377-Z	TO-252		

### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

	Drain to Source Voltage	Voss	60	V
	Gate to Source Voltage	Vgss	±20	V
	Drain Current (DC)	ID(DC)	±20	Α
*	Drain Current (Pulse) Note1	D(pulse)	±50	Α
	Total Power Dissipation (Tc = 25°C)	Рт	30	W
	Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.0	W
	Channel Temperature	Tch	150	°C
	Storage Temperature	Tstg	-55 to +150	°C
*	Single Avalanche Current Note2	las	15	Α
*	Single Avalanche Energy Note2	Eas	23	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

2. Starting Tch = 25 °C, RG = 25  $\Omega$ , VGS = 20 V  $\rightarrow$  0 V

### THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	4.17	°C/W
Channel to Ambient	Rth(ch-A)	125	°C/W

(TO-251)



(TO-252



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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

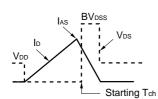


### **\*** ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C)

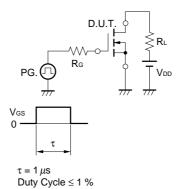
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	V <sub>G</sub> S = 10 V, I <sub>D</sub> = 10 A		35	44	mΩ
	RDS(on)2	Vgs = 4.0 V, ID = 10 A		54	78	mΩ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 10 A	5	10		S
Drain Leakage Current	IDSS	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	V <sub>G</sub> S = ±20 V, V <sub>D</sub> S = 0 V			±10	μΑ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		760		pF
Output Capacitance	Coss	Vss = 0 V		150		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		71		pF
Turn-on Delay Time	<b>t</b> d(on)	ID = 10 A		13		ns
Rise Time	<b>t</b> r	V <sub>GS(on)</sub> = 10 V		170		ns
Turn-off Delay Time	td(off)	V <sub>DD</sub> = 30 V		43		ns
Fall Time	<b>t</b> f	$R_G = 10 \Omega$		34		ns
Total Gate Charge	Q <sub>G</sub>	ID = 20 A		17		nC
Gate to Source Charge	Qgs	V <sub>DD</sub> = 48 V		3.0		nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS(on)</sub> = 10 V		4.7		nC
Body Diode Forward Voltage	VF(S-D)	IF = 20 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 20 A, VGS = 0 V		39		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		62		nC

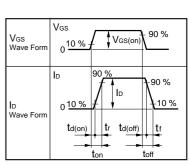
### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{RG} = 25 \ \Omega \\ \text{PG.} \\ \text{Vos} = 20 \rightarrow 0 \ \text{V} \\ \text{m} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{PG.} \\ \text{Vpp} \end{array}$

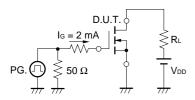


### **TEST CIRCUIT 2 SWITCHING TIME**





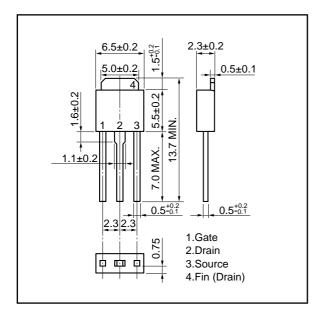
### **TEST CIRCUIT 3 GATE CHARGE**



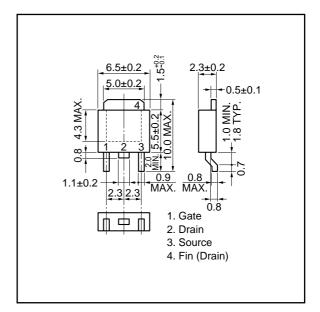


### PACKAGE DRAWINGS (Unit: mm)

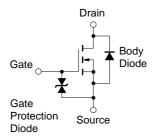
### 1) TO-251 (MP-3)



### 2) TO-252 (MP-3Z)



### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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